

# Features

- Short Circuit Rated 10us
- High Current Capability
- High Input Impedance
- Fast Switching
- RoHS Compliant

## March 2013

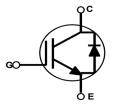
# **General Description**

Using advanced NPT IGBT technology, Fairchild<sup>®</sup>'s the NPT IGBTs offer the optimum performance for low-power inverterdriven applications where low-losses and short-circuit ruggedness features are essential, such as sewing machine, CNC, motor control and home appliances.

# Applications

· Sewing Machine, CNC, Home Appliances, Motor Control





## **Absolute Maximum Ratings**

Symbol	Description	Ratings	Unit	
V <sub>CES</sub>	Collector to Emitter Voltage		600	V
V <sub>GES</sub>	Gate to Emitter Voltage		± 20	V
I <sub>C</sub>	Collector Current	@ T <sub>C</sub> = 25°C	20	A
	Collector Current	@ T <sub>C</sub> = 100°C	10	A
I <sub>CM (1)</sub>	Pulsed Collector Current	@ T <sub>C</sub> = 25°C	30	A
I <sub>F</sub>	Diode Forward Current	@ T <sub>C</sub> = 25°C	10	A
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	139	W
	Maximum Power Dissipation	@ T <sub>C</sub> = 100 <sup>o</sup> C	56	W
TJ	Operating Junction Temperature		-55 to +150	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

# **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case	-	0.9	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	-	3.5	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (PCB Mount)(2)	-	62.5	°C/W

Notes:

2: Mountde on 1" square PCB (FR4 or G-10 material)

-		Device Pa		Packaging Ackage Type		Qty per Tube		Max Qty per Box	
		TO220	Tube	50	lea	-			
Electric	al Cha	racteristics of	the I		5°C unless otherwise noted				
Symbol			Test Conditions		Min.	Тур.	Max.	Unit	
Off Charac	teristics								
BV <sub>CES</sub>	Collector	to Emitter Breakdown V	/oltage	V <sub>GE</sub> = 0 V, I	<sub>C</sub> = 250 μA	600	-	-	V
I <sub>CES</sub>	Collector	Cut-Off Current	-	V <sub>CE</sub> = V <sub>CES</sub> ,		-	-	1	mA
I <sub>GES</sub>	G-E Leak	age Current		V <sub>GE</sub> = V <sub>GES</sub>		-	-	±10	uA
On Charac	teristics								
V <sub>GE(th)</sub>	G-E Thre	shold Voltage		I <sub>C</sub> = 10 mA,	V <sub>CE</sub> = V <sub>GE</sub>	5.5	6.8	8.5	V
()		-		I <sub>C</sub> = 10 A, V <sub>C</sub>		-	2	2.45	V
V <sub>CE(sat)</sub>	Collector	Collector to Emitter Saturation Voltage			$I_{C} = 10 \text{ A}, V_{GE} = 15 \text{ V},$ $T_{C} = 125^{\circ}\text{C}$		2.3	-	V
Dynamic C	haracteris	atics							
C <sub>ies</sub>	1					-	517		pF
C <sub>oes</sub>	Output C	apacitance		$V_{CE} = 30 V, V_{GE} = 0 V,$		-	65		pF
C <sub>res</sub>	Reverse	Transfer Capacitance		f = 1 MHz		-	20		pF
Switching	Character	istics		•					
t <sub>d(on)</sub>		Delay Time				-	8.0		ns
t <sub>r</sub>	Rise Time	e		-		-	6.3		ns
t <sub>d(off)</sub>	Turn-Off	Delay Time		$V_{00} = 400 V_{00}$	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 10 A,		52.2		ns
t <sub>f</sub>	Fall Time	-		R <sub>G</sub> = 10 Ω, <sup>v</sup>	V <sub>GE</sub> = 15 V,	-	19.1	24.8	ns
E <sub>on</sub>	Turn-On	Switching Loss		Inductive Lo	ad, T <sub>C</sub> = 25 <sup>o</sup> C	-	0.15		uJ
E <sub>off</sub>		Switching Loss		1		-	0.05		uJ
E <sub>ts</sub>	Total Swi	tching Loss		-		-	0.2		uJ
t <sub>d(on)</sub>	Turn-On	Delay Time				-	8.1		ns
t <sub>r</sub>	Rise Time	9		1		-	7.3		ns
t <sub>d(off)</sub>	Turn-Off	Delay Time		V <sub>CC</sub> = 400 V	/, I <sub>C</sub> = 10 A,	-	55.1		ns
t <sub>f</sub>	Fall Time			R <sub>G</sub> = 10 Ω, <sup>v</sup>	<sub>G</sub> = 10 Ω, V <sub>GE</sub> = 15 V,	-	34.2		ns
E <sub>on</sub>	Turn-On	Switching Loss	Inductive Load		ad, T <sub>C</sub> = 125ºC	-	0.22		uJ
E <sub>off</sub>	Turn-Off	Switching Loss				-	0.08		uJ
E <sub>ts</sub>	Total Swi	tching Loss				-	0.3		uJ
T <sub>sc</sub>	Short Cire	cuit Withstand Time	V <sub>CC</sub> = 350 N R <sub>G</sub> = 100 Ω T <sub>C</sub> = 150°C		/, , V <sub>GE</sub> = 15V ,	10	-	-	μS

<b>Electrical Characteristics of the IGBT</b>	T <sub>C</sub> = 25°C unless otherwise noted
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Symbol	Parameter	Test Conditions	Min.	Тур.	Мах	Unit
Qg	Total Gate Charge		-	37		nC
Q <sub>ge</sub>	Gate to Emitter Charge	V <sub>CE</sub> = 400 V, I <sub>C</sub> = 10 A, V <sub>GE</sub> = 1 V	-	5		nC
Q <sub>gc</sub>	Gate to Collector Charge	GE - I V	-	21		nC

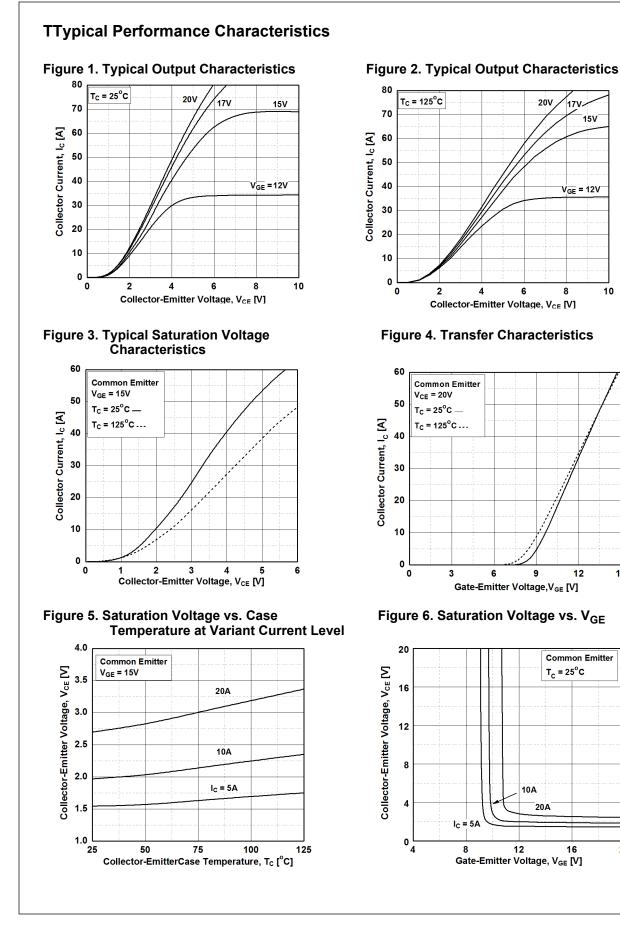
# Electrical Characteristics of the Diode $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Мах	Unit
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 10 A	T <sub>C</sub> = 25°C	-	1.8	2.2	V
* FIM	2.040 · O.Mara · O.Mago		T <sub>C</sub> = 125°C	-	1.7		
t <sub>rr</sub>	Diode Reverse Recovery Time	$T_{\rm F} = 10$ A, $dT_{\rm F}/dt = 200$ A/µs	T <sub>C</sub> = 25°C	-	37.7		ns
41			T <sub>C</sub> = 125 <sup>o</sup> C	-	78.9		
Q <sub>rr</sub>	Diode Reverse Recovery Charge		T <sub>C</sub> = 25°C	-	75		nC
~"	Diede Hereiter Hereiter ge		T <sub>C</sub> = 125 <sup>o</sup> C	-	221		

15V

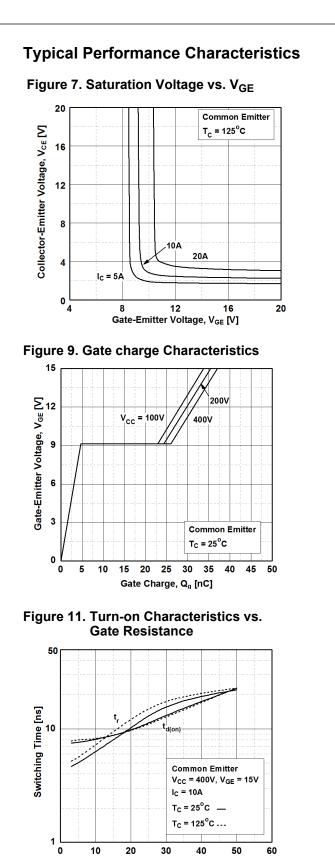
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15

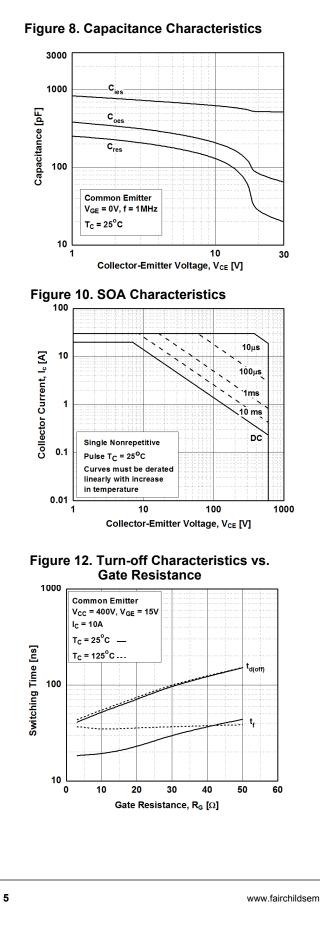


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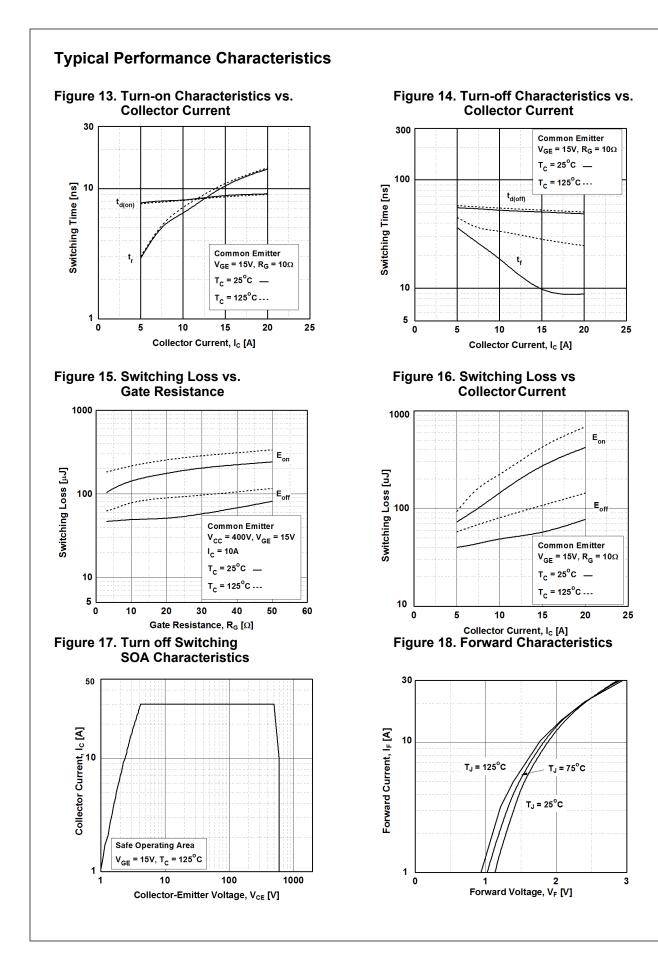
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Gate Resistance, R<sub>G</sub> [Ω]



FGP10N60UNDF 600 V, 10 A Short Circuit Rated IGBT



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6

200A/µs

di/dt = 100A/µs

di/dt = 100A/µs

10

12

8

6

Forward Current, I<sub>F</sub> [A]

200A/µs

# **Typical Performance Characteristics**

## Figure 19. Reverse Recovery Current



T<sub>C</sub> = 25°C

T<sub>C</sub> = 125°C ...

2

4

0.3

0.2

0.1

0.0

0

Stored Recovery charge, Q<sub>rr</sub> [ns]

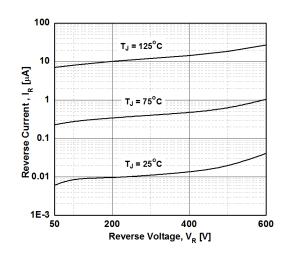
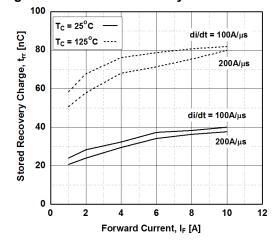
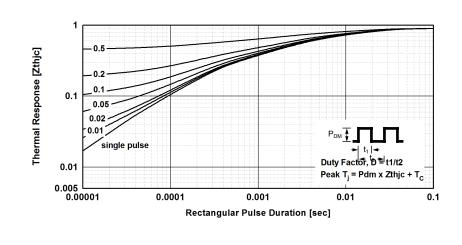
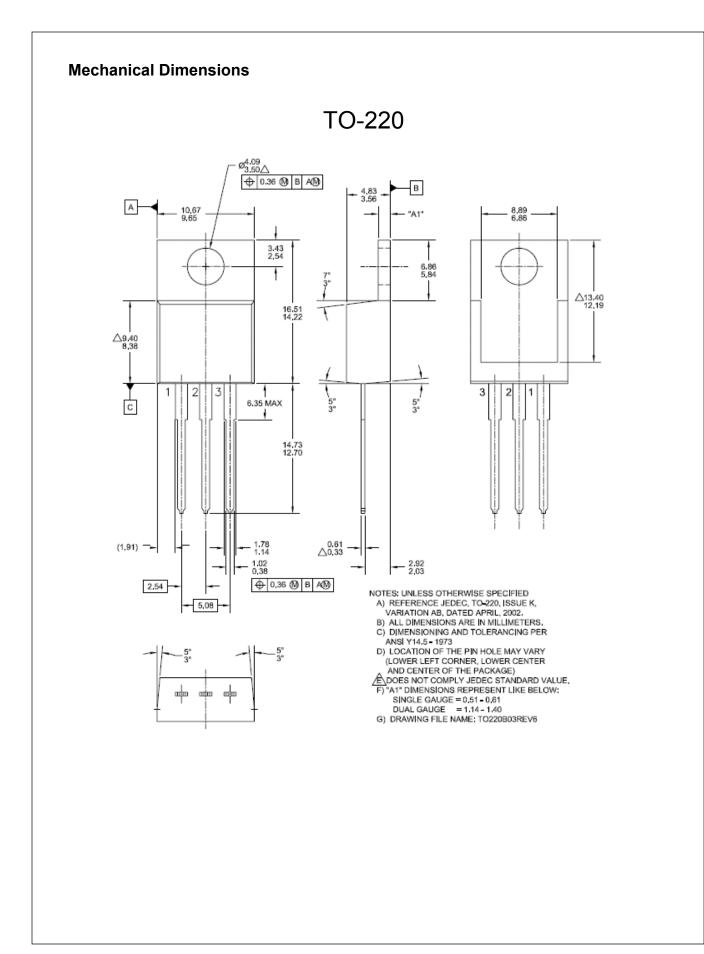


Figure 21. Reverse Recovery Time









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